

General Description

The CMP40P03 is a P-channel Power MOSFET. It has specifically been designed to minimize input capacitance and gate charge. The device is therefore suitable in advanced high-efficiency switching applications.

Features

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

Absolute Maximum Ratings

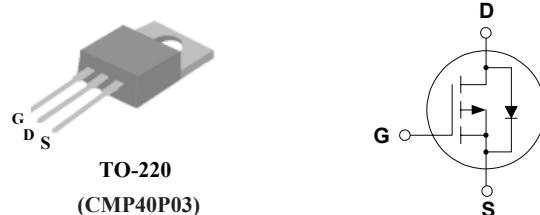
Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	-30	V
V_{GS}	Gate-Source Voltage	± 20	V
$I_D @ T_C = 25^\circ C$	Continuous Drain Current ¹	-40	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current ¹	-20	A
I_{DM}	Pulsed Drain Current ²	-120	A
$P_D @ T_C = 25^\circ C$	Total Power Dissipation	80	W
T_{STG}	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C

Product Summary

BVDSS	RDSON	ID
-30V	14mΩ	-40A

Applications

- LED POWER CONTROLLER
- DC-DC & DC-AC CONVERTERS
- HIGH CURRENT, HIGH SPEED SWITCHING
- SOLENOID AND RELAY DRIVERS
- MOTOR CONTROL, AUDIO AMPLIFIERS

TO220 Pin Configuration**Thermal Data**

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient ¹	---	65	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-case	---	3.72	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=-250\mu\text{A}$	-30	---	---	V
$\Delta BV_{DSS}/\Delta T_J$	BVDSS Temperature Coefficient	Reference to $25^\circ\text{C}, I_D=-1\text{mA}$	---	-0.01	---	$\text{V}/^\circ\text{C}$
$R_{DS(ON)}$	Static Drain-Source On-Resistance ²	$V_{GS}=-10\text{V}, I_D=-24\text{A}$	---	---	14	$\text{m}\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\mu\text{A}$	-1	---	-3	V
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=-30\text{V}, V_{GS}=0\text{V}$	---	---	-1	μA
		$V_{DS}=-24\text{V}, V_{GS}=0\text{V} @ 125^\circ\text{C}$	---	---	-25	
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$	---	---	± 100	nA
g_{fs}	Forward Transconductance	$V_{DS}=-10\text{V}, I_D=-24\text{A}$	---	35	---	S
Q_g	Total Gate Charge	$I_D=-24\text{A}$	---	30	55	nC
Q_{gs}	Gate-Source Charge	$V_{DS}=-24\text{V}$	---	6	---	
Q_{gd}	Gate-Drain Charge	$V_{GS}=-4.5\text{V}$	---	25	---	
$T_{d(on)}$	Turn-On Delay Time	$V_{DS}=-15\text{V}$	---	10	---	ns
T_r	Rise Time	$I_D=-24\text{A}$	---	65	---	
$T_{d(off)}$	Turn-Off Delay Time	$R_G=3.3\Omega, V_{GS}=-10\text{V}$	---	60	---	
T_f	Fall Time	$R_D=0.63\Omega$	---	100	---	
C_{iss}	Input Capacitance	$V_{DS}=-25\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$	---	2200	3395	pF
C_{oss}	Output Capacitance		---	635	---	
C_{rss}	Reverse Transfer Capacitance		---	560	---	

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
t_{rr}	Reverse Recovery Time ²	$V_{GS}=0\text{V}, I_S=-24\text{A}$ $dI/dt=-100\text{A}/\mu\text{s}$	---	39	---	ns
Q_{rr}	Reverse Recovery Charge		---	38	---	nC
V_{SD}	Diode Forward Voltage ²	$V_{GS}=0\text{V}, I_S=-24\text{A}, T_J=25^\circ\text{C}$	---	---	-1.2	V

Note :

1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.2.The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$